

References

- [1]. R. Miyazawa *et al.*, *Journal of Vacuum Science and Technology B*, **2024**, 42, 022213.

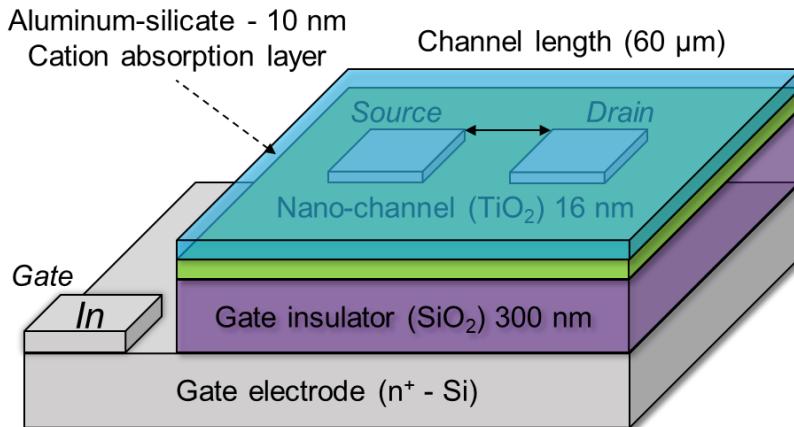


Fig.1 Schematic of TiO_2 -TFT with aluminum-silicate and SiO_2 multiple films.

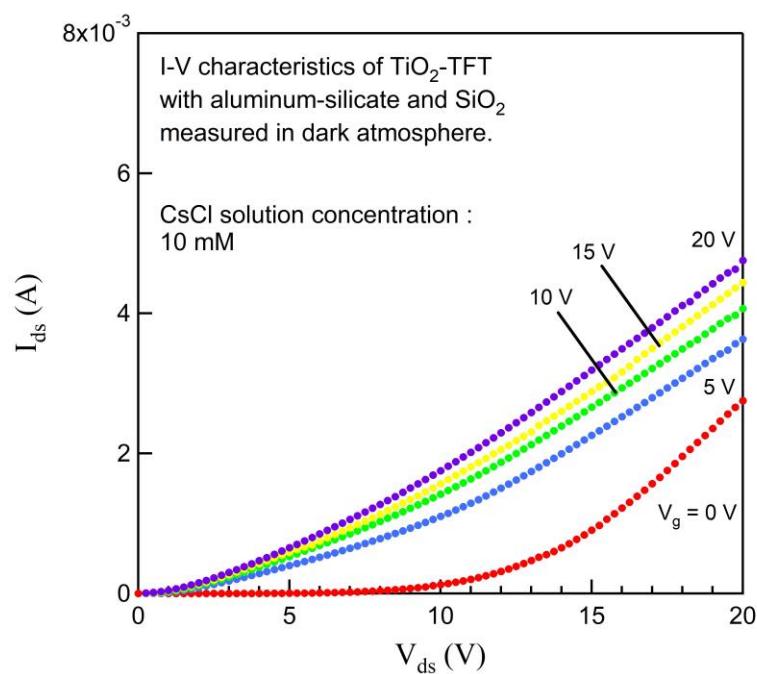


Fig.2 I-V characteristics of TiO_2 -TFT after immersion CsCl solutions.

CsCl solution concentration: 10 mM